

# Search Notes



Application/Control No.

10/632,625

Examiner

Anthony Fick

Applicant(s)/Patent under Reexamination

TERAO ET AL.

Art Unit

1753

## SEARCHED

Class	Subclass	Date	Examiner
52	173.3	11/28/2006	ADF
136	246	11/28/2006	ADF
updated ↓	4/26/07	ADF	
updated ↓	7/13/07	ADF	

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
word search, see EAST history	7/13/07	ADF	

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
See EAST search history	11/28/2006	ADF
Inventor search	11/28/2006	ADF
Consulted with Jeffrey Barton and Nam Nguyen	11/28/2006	ADF